

Notice of References Cited	Application/Control No. 10/566,604	Applicant(s)/Patent Under Reexamination MORIYA ET AL.	
	Examiner Hai H. Huynh	Art Unit 3747	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,598,468 B2	07-2003	Zur Loye et al.	73/117.3
*	B	US-7,113,861 B2	09-2006	Jacobson, Evan Earl	701/101
*	C	US-2006/0129307 A1	06-2006	Yasui, Yuji	701/114
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 1653071	05-2006		Moriya et al	F02D 45/00
	O	JP 2005-207407	08-2005	Japan	Moriya	F02D 45/00
	P	JP 2006-70885	03-2006	Japan	Goya et al	F02D 45/00
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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